NOTES:

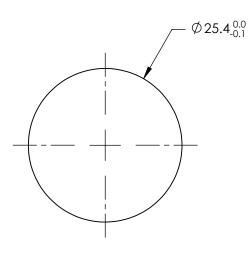
1. SUBSTRATE MATERIAL: Fused Silica

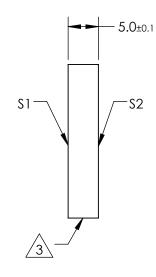
- 2. COATING (APPLY ACROSS CLEAR APERTURE)
 - S1: Dielectric

REFLECTIVITY (Rs%, Rp%): >99.8 REFLECTIVITY (Rp%): 99.7 REFLECTIVITY (Rs%): 99.9 DAMAGE THRESHOLD (PULSED): >12 J/cm² @ 1064nm, 10ns DURABILITY: MIL-C-675A S2: NONE

3. FINE GROUND SURFACE

4. RoHS COMPLIANT





SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE DIMENSIONS ARE FOR REFERENCE ONLY

	S1	S2					
SHAPE	PLANO	PLANO				Edmund Optic	C ®
CLEAR APERTURE (%)	>90	N/A					5
SURFACE QUALITY	20-10	COMMERCIAL POLISH			TITLE	255 mm AFR OF Amm Dig NidiVAC IDS Low	
SURFACE FLATNESS	λ/8	N/A				355nm, 45° 25.4mm Dia. Nd:YAG IBS Low Loss Laser Line Mirror	LOW
WAVELENGTH RANGE (nm)	343 - 355	N/A					0.1557
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN	mm	DWG NO	89450	SHEET 1 OF 1

FOR INFORMATION ONLY: DO NOT MANUFACTURE PARTS TO THIS DRAWING